

Search Notes

Application/Control No.

10/666,205

Examiner

YONG D. PAK

Applicant(s)/Patent under
Reexamination

STAMPFER ET AL.

Art Unit

1652

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
435	190	4/7/2009	YP
435	440	4/7/2009	YP
435	69.1	4/7/2009	YP
stic: seq id no:48		4/7/2009	YP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (all databases): text and inventor search, see search history	4/7/2009	YP
PALM: inventor search	4/7/2009	YP
STIC: SEQ ID NO:48, see score	4/7/2009	YP